


<b>Search Notes</b>  	<b>Application/Control No.</b>  10644009	<b>Applicant(s)/Patent Under Reexamination</b>  TAKEUCHI ET AL.
	<b>Examiner</b>  Tran, Philip B	<b>Art Unit</b>  2155

SEARCHED			
Class	Subclass	Date	Examiner
709	245, 242, 238, 225, 227-228, 230	6/20/2007	PBT
370	392-393, 466, 389,400	6/20/2007	PBT

SEARCH NOTES		
Search Notes	Date	Examiner
East and NPL	6/20/07	PBT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner